Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/619,046	HAN ET AL.
Examiner	Art Unit
Khai M Nguyen	2687

SEARCHED				
Class	Subclass	Date	Examiner	
455	436 444 446 449	10/20/2005	KN	
			-	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
		•		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East (see attached)		KN		
	,			
		_		